

23rd International Congress on X-ray Optics and Microanalysis (ICXOM23)

Tuesday, 15 September 2015

X-ray Optics II - Berkner Hall, Auditorium (13:30 - 15:10)

time	[id] title	presenter
13:30	[27] Zone plates for nanoscale X-ray imaging	REHBEIN, Stefan
14:10	[28] Application and optics concepts for scanning and full-field X-ray microscopy with multilayer Laue lenses	NIESE, Sven
14:30	[29] High-energy X-ray focused microbeam by using KB mirrors and sagittal bent Laue monochromator	HONG, Xinguo
14:50	[30] A Large Area Rapid Imaging Analysis Tool	WEILAND, Conan